Se	arc	h N	Voi	tes
				$\cdot \cdot \cdot$



Application/Control No.	Applicant(s)/Patent under Reexamination
10/799,741	RIMMER ET AL.
Examiner	Art Unit
Riph V. Ho	2821

SEARCHED			
Class	Subclass	Date	Examiner
315	291	1/12/2006	ВН

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
315	291	1/12/2006	вн
315	194	1/12/2006	ВН

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
315/194,209R,307;307/150,174/104 East search (see printout)	1/12/2006	вн
315/194,209R,307;307/150,174/104 (US Pub search)	1/12/2006	вн
East seach (Inventors)	1/12/2006	вн
Consulted Trinh (Primary 315)	1/12/2006	вн